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MOS-TECH Semiconductor Co.,LTD 臺 灣 茂 鈿 半 導 體 股 份 有 限 公 司

Dual N-Channel Power ACG: 9H

Features

■ 7.1A, 20V r_{DS(ON)} =0.0FÌ Ω, V_{GS} = 4.5V

 $r_{DS(ON)} = 0.025\Omega, V_{GS} = 2.5V$

- \blacksquare Extended V_{GS} range (±12 V) for battery applications
- HBM ESD Protection Level of 3.5kV Typical (note 3)
- High performance trench technology for extremely low r_{DS(ON)}
- Low profile TSSOP-8 package

Applications

- Load switch
- Battery charge
- Battery disconnect circuits



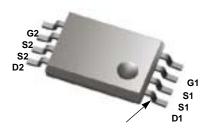
General Description

electronics applications.

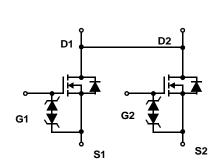
This N-ChannelÁMOSFETÁsáproducedÁusingÁT UÙË/ÒÔP Semiconductor's advanced PowerTrench process that has

been especially tailored to minimize the on-state resistance

and yet maintain low gate charge for superior switching performance. These devices are well suited for portable



TSSOP-8 Pin 1



Symbo	Parameter				Ratings			Units
√ _{DSS}	Drain to S	Source Voltage			20			V
/ _{GS}	Gate to S	ource Voltage			±12			V
	Drain Cur		_					
D	Continuous (T _C = 25 ^o C, V _{GS} = 4.5V, R _{θJA} = 77 ^o C/W) Continuous (T _C = 100 ^o C, V _{GS} = 2.5V, R _{θJA} = 77 ^o C/W)			7.1			Α	
D	Continuous (T _C = 100 ^o C, V _{GS} = 2.5V, $R_{\theta JA}$ = 77 ^o C/W)				4.0			A
	Pulsed					Figure 4		A
` D	Power dis					1.6		W
		Derate above 25°C			13			mW/ºC
J, T _{STG}	Operating	and Storage Temperatu	ire		-	-55 to 150)	°C
herm	al Chara	cteristics						
R _{0JA}	Thermal F	Resistance Junction to A	mbient (Note 1)			77		°C/W
R _{0JA}	Thermal F	Resistance Junction to A	mbient (Note 2)			114		°C/W
Device	e Marking	ng and Ordering Device	Package	Reel Size		Width	Qua	
FC	ÆP A		WWWWTSSOP-8/WWWW	XXXXXXXX 3" /XXXXXXXX	XXXXXXXX 2	mm	Ó	units
Symbol	ical Char	acteristics T _A = 29 Parameter s	5°C unless otherwise Test Cor		Min	Тур	Max	Units
Symbol Off Cha	racteristic	Parameter	Test Cor	nditions	Min 20	Тур	Max -	Units
Symbol Off Cha ³ vdss	Tracteristic	Parameter S rce Breakdown Voltage		nditions		- -	Max - 1	V
Symbol	Tracteristic	Parameter S	Test Cor I _D = 250μA, V _{GS} V _{DS} = 16V	nditions	20	- - -	-	
Symbol Off Cha ³ vdss dss	Drain to Sour	Parameter S Cce Breakdown Voltage Oltage Drain Current	$\begin{tabular}{ l_D = 250 \mu A, V_{GS} \\ \hline V_{DS} = 16V \\ \hline V_{GS} = 0V \end{tabular}$	editions	20	Typ - - - -	- 1	V
Symbol Off Cha ³ vdss	Drain to Sour	Parameter S rce Breakdown Voltage	Test Cor I _D = 250μA, V _{GS} V _{DS} = 16V	editions	20 - -	- - - -	- 1 5	V µA
Symbol Off Cha BVDSS DSS GSS	Drain to Sour	Parameter S Ce Breakdown Voltage Oltage Drain Current Ce Leakage Current	Test Cor $I_D = 250 \mu A, V_{GS}$ $V_{DS} = 16V$ $V_{GS} = 0V$ $V_{GS} = \pm 12V$	editions	20 - -	- - - -	- 1 5 ±10	۷ μΑ μΑ
Symbol Off Cha 3vDSS DSS GSS On Cha	Drain to Sour Zero Gate Vo Gate to Sour	Parameter S Ce Breakdown Voltage Oltage Drain Current Ce Leakage Current	Test Cor $I_D = 250\mu A, V_{GS}$ $V_{DS} = 16V$ $V_{GS} = 0V$ $V_{GS} = \pm 12V$ $V_{GS} = \pm 4.5V$ $V_{GS} = V_{DS}, I_D = 2$	e 0V T _A =100 ^o C	20 - -	- - - -	- 1 5 ±10	۷ μΑ μΑ
Symbol Off Cha 3VDSS DSS GSS On Cha	Drain to Sour Zero Gate Vo Gate to Sour	Parameter S Cce Breakdown Voltage Oltage Drain Current Cce Leakage Current S	$\begin{tabular}{ c c c c } \hline Test Cor \\ \hline I_D = 250 \mu A, V_{GS} \\ \hline V_{DS} = 16V \\ \hline V_{GS} = 0V \\ \hline V_{GS} = 0V \\ \hline V_{GS} = \pm 12V \\ \hline V_{GS} = \pm 4.5V \\ \hline \end{tabular}$	e 0V T _A =100 ^o C	20 - -	-	- 1 5 ±10 ±250	V μΑ μΑ nA
Symbol Off Cha BVDSS DSS GSS On Cha	racteristic: Drain to Sour Zero Gate Vo Gate to Sour racteristic: Gate to Sour	Parameter S Cce Breakdown Voltage Oltage Drain Current Cce Leakage Current S Cce Threshold Voltage	$\begin{tabular}{ c c c c } \hline Test Cor \\ \hline I_D = 250 \mu A, V_{GS} \\ \hline V_{DS} = 16V \\ \hline V_{GS} = 0V \\ \hline V_{GS} = 0V \\ \hline V_{GS} = \pm 12V \\ \hline V_{GS} = \pm 4.5V \\ \hline \hline U_{GS} = V_{DS}, I_D = 2 \\ \hline I_D = 7.1A, V_{GS} = \\ \hline I_D = 6.9A, V_{GS} = 1 \\ \hline \hline \end{bmatrix} \end{tabular}$	e 0V T _A =100°C 250μA 4.5V 4.0V	20 - -	- - - 0.8 0.015 0.015	- 1 5 ±10 ±250 1.5 0.0FÌ Å	V μΑ μΑ nA
Symbol Off Cha SVDSS DSS On Cha (GS(TH)	racteristic: Drain to Sour Zero Gate Vo Gate to Sour racteristic: Gate to Sour	Parameter S Cce Breakdown Voltage Oltage Drain Current Cce Leakage Current S	$\begin{tabular}{ c c c c } \hline Test Cor \\ \hline I_D = 250 \mu A, V_{GS} \\ \hline V_{DS} = 16V \\ \hline V_{GS} = 0V \\ \hline V_{GS} = 0V \\ \hline V_{GS} = \pm 12V \\ \hline V_{GS} = \pm 4.5V \\ \hline \hline U_{GS} = \pm 4.5V \\ \hline \hline I_D = 7.1A, V_{GS} = \\ \hline I_D = 6.9A, V_{GS} = \\ \hline I_D = 6.5A, V_{GS} = \\ \hline \end{tabular}$	aditions = 0V T _A =100°C 250μA 4.5V 4.0V 3.1V	20 - - - 0.6 -	- - - 0.8 0.015	- 1 5 ±10 ±250 1.5 0.0FÌ #	V μΑ ηΑ Ν
Symbol Off Cha B _{VDSS} DSS GSS	racteristic: Drain to Sour Zero Gate Vo Gate to Sour racteristic: Gate to Sour	Parameter S Cce Breakdown Voltage Oltage Drain Current Cce Leakage Current S Cce Threshold Voltage	$\begin{tabular}{ c c c c } \hline Test Cor \\ \hline I_D = 250 \mu A, V_{GS} \\ \hline V_{DS} = 16V \\ \hline V_{GS} = 0V \\ \hline V_{GS} = 0V \\ \hline V_{GS} = \pm 12V \\ \hline V_{GS} = \pm 4.5V \\ \hline \hline U_{GS} = V_{DS}, I_D = 2 \\ \hline I_D = 7.1A, V_{GS} = \\ \hline I_D = 6.9A, V_{GS} = 1 \\ \hline \hline \end{bmatrix} \end{tabular}$	aditions = 0V T _A =100°C 250μA 4.5V 4.0V 3.1V	20 - - - 0.6 -	- - - 0.8 0.015 0.015	- 1 5 ±10 ±250 1.5 0.0FÌ Å	V μΑ ηΑ Ν ν
Symbol Off Cha 3 <u>VDSS</u> DSS GSS On Cha (GS(TH) DS(ON)	racteristic: Drain to Sour Zero Gate Vo Gate to Sour racteristic: Gate to Sour	Parameter S CCC Breakdown Voltage Oltage Drain Current CCC Leakage Current S CCC Threshold Voltage CCC On Resistance	$\begin{tabular}{ c c c c } \hline Test Cor \\ \hline I_D = 250 \mu A, V_{GS} \\ \hline V_{DS} = 16V \\ \hline V_{GS} = 0V \\ \hline V_{GS} = 0V \\ \hline V_{GS} = \pm 12V \\ \hline V_{GS} = \pm 4.5V \\ \hline \hline U_{GS} = \pm 4.5V \\ \hline \hline I_D = 7.1A, V_{GS} = \\ \hline I_D = 6.9A, V_{GS} = \\ \hline I_D = 6.5A, V_{GS} = \\ \hline \end{tabular}$	aditions = 0V T _A =100°C 250μA 4.5V 4.0V 3.1V	20 - - - 0.6 -	- - - - 0.8 0.015 0.015 0.016	- 1 5 ±10 ±250 1.5 0.0Fì Å 0.021 0.024	V μΑ μΑ Ω
Symbol Off Cha BVDSS DSS DSS On Cha (GS(TH) DS(ON)	racteristic: Drain to Sour Zero Gate Vo Gate to Sour racteristic: Gate to Sour Drain to Sour	Parameter S CCE Breakdown Voltage Oltage Drain Current CCE Leakage Current S CCE Threshold Voltage CCE On Resistance CCE On Resistance CCE S CCE	$\begin{tabular}{ c c c c } \hline Test Cor \\ \hline I_D = 250 \mu A, V_{GS} \\ \hline V_{DS} = 16V \\ \hline V_{GS} = 0V \\ \hline V_{GS} = 0V \\ \hline V_{GS} = \pm 12V \\ \hline V_{GS} = \pm 4.5V \\ \hline \hline V_{GS} = \pm 4.5V \\ \hline \hline I_D = 7.1A, V_{GS} = \\ \hline I_D = 6.9A, V_{GS} = \\ \hline I_D = 6.5A, V_{GS} = \\ \hline I_D = 6.3A, V_{GS} = \\ \hline \hline \hline I_D = 6.3A, V_{GS} = \\ \hline \hline \hline I_D = 6.3A, V_{GS} = \\ \hline \hline \hline I_D = 6.3A, V_{GS} = \\ \hline \hline \hline \hline I_D = 6.3A, V_{GS} = \\ \hline \hline \hline \hline I_D = 6.3A, V_{GS} = \\ \hline \hline \hline \hline \hline I_D = 6.3A, V_{GS} = \\ \hline \hline$	editions = 0V T _A =100°C 250μA 4.5V 4.0V 3.1V 2.5V	20 - - - 0.6 -	- - - - 0.8 0.015 0.015 0.016	- 1 5 ±10 ±250 1.5 0.0Fì Å 0.021 0.024	V μΑ μΑ Ω
Symbol off Cha over the second over the second	racteristic: Drain to Sour Zero Gate Vo Gate to Sour racteristic: Gate to Sour Drain to Sour	Parameter S CCE Breakdown Voltage Oltage Drain Current CCE Leakage Current S CCE Threshold Voltage CCE On Resistance CCE On Resistance CCE S CCE	$\begin{tabular}{ l_D = 250 \mu A, V_{GS} \\ V_{DS} = 16V \\ V_{GS} = 0V \\ \hline V_{GS} = 0V \\ \hline V_{GS} = \pm 12V \\ \hline V_{GS} = \pm 4.5V \\ \hline \hline V_{GS} = \pm 4.5V \\ \hline \hline \\ I_D = 7.1A, V_{GS} = \\ \hline I_D = 6.9A, V_{GS} = \\ \hline \\ I_D = 6.5A, V_{GS} = \\ \hline \\ I_D = 6.3A, V_{GS} = \\ \hline \\ \hline \\ V_{DS} = 10V, V_{GS} = 10V \\ \hline \\ \hline \end{tabular}$	editions = 0V T _A =100°C 250μA 4.5V 4.0V 3.1V 2.5V	20 - - - - - - - - -	- - - - 0.8 0.015 0.015 0.015 0.016 0.017	- 1 5 ±10 ±250 1.5 0.0FÌ & 0.021 0.024 0.025	V μΑ πΑ Ω Ω
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Symbol Off Cha BVDSS DSS DSS DSS DSS DN Cha CSS COSS COSS COSS CSS CSS CSS CSS CSS	racteristic: Drain to Sour Zero Gate Vo Gate to Sour racteristic: Gate to Sour Drain to Sour Drain to Sour ic Characte Input Capacit Output Capa Reverse Tran Gate Resista	Parameter S Parameter Parame	$\begin{tabular}{ c c c c } \hline Test Cor \\ \hline I_D = 250 \mu A, V_{GS} \\ \hline V_{DS} = 16V \\ \hline V_{GS} = 0V \\ \hline V_{GS} = 0V \\ \hline V_{GS} = \pm 12V \\ \hline V_{GS} = \pm 4.5V \\ \hline \hline U_{GS} = \pm 4.5V \\ \hline \hline U_{DS} = 10V, V_{GS} = 1000 \\ \hline I_D = 6.5A, V_{GS} = 1000 \\ \hline I_D = 6.3A, V_{GS} = 1000 \\ \hline V_{DS} = 10000, V_{GS} = 10000 \\ \hline V_{GS} = 0.5V, f = 10000 \\ \hline V_{GS} = 0.5V, f = 10000 \\ \hline \hline V_{GS} = 0.5V, f = 10000 \\ \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline \hline \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline \hline \hline \hline \hline \hline \hline V_{SS} = 0.5V, f = 10000 \\ \hline \hline$	nditions = $0V$ $T_A = 100^{\circ}C$ 250 μ A 4.5V 4.0V 3.1V 2.5V = $0V$, MHz $V_{DD} = 10V$	20 - - - - - - - - - - - -	- - - - 0.8 0.015 0.015 0.015 0.016 0.017 1000 250 175 2.8	- 1 5 ±10 ±250 1.5 0.0Fì Å 0.021 0.024 0.025	V μA ηA ηA
Symbol Off Cha 3VDSS DSS GSS On Cha (GS(TH) DS(ON)	racteristic: Drain to Sour Zero Gate Vo Gate to Sour racteristic: Gate to Sour Drain to Sour Drain to Sour Drain to Sour Drain to Sour Characte Input Capaci Output Capaci Output Capaci Gate Resista Total Gate Cl Total Gate Cl	Parameter S Parameter Parame	$\begin{tabular}{ c c c c } \hline Test Cor \\ \hline I_D = 250 \mu A, V_{GS} \\ \hline V_{DS} = 16V \\ \hline V_{GS} = 0V \\ \hline V_{GS} = 0V \\ \hline V_{GS} = \pm 12V \\ \hline V_{GS} = \pm 4.5V \\ \hline \hline V_{GS} = \pm 4.5V \\ \hline \hline U_D = 7.1A, V_{GS} = \\ \hline I_D = 6.9A, V_{GS} = \\ \hline I_D = 6.5A, V_{GS} = \\ \hline I_D = 6.3A, V_{GS} = \\ \hline V_{DS} = 10V, V_{GS} = \\ \hline F = 1MHz \\ \hline V_{GS} = 0.5V, f = 1 \\ \hline V_{GS} = 0V to 4.5V \\ \hline \end{tabular}$	e 0V T _A =100°C 250µA 4.5V 4.0V 3.1V 2.5V = 0V, MHz	20 - - - - - - - - - - - - -	- - - - - - - - - - - - - - - - - - -	- 1 5 ±10 ±250 1.5 0.0Fì Å 0.021 0.024 0.025 - - - - - 17.3	V μA ηA ηA

Switch	Switching Characteristics (V _{GS} = 4.5V)							
t _{ON}	Turn-On Time		-	-	146	ns		
t _{d(ON)}	Turn-On Delay Time		-	13	-	ns		
t _r	Rise Time	V _{DD} = 10V, I _D = 7.1A	-	84	-	ns		
t _{d(OFF)}	Turn-Off Delay Time	$V_{GS} = 4.5 V, R_{GS} = 6.8 \Omega$	-	41	-	ns		
t _f	Fall Time]	-	55	-	ns		
t _{OFF}	Turn-Off Time		-	-	144	ns		

Drain-Source Diode Characteristics

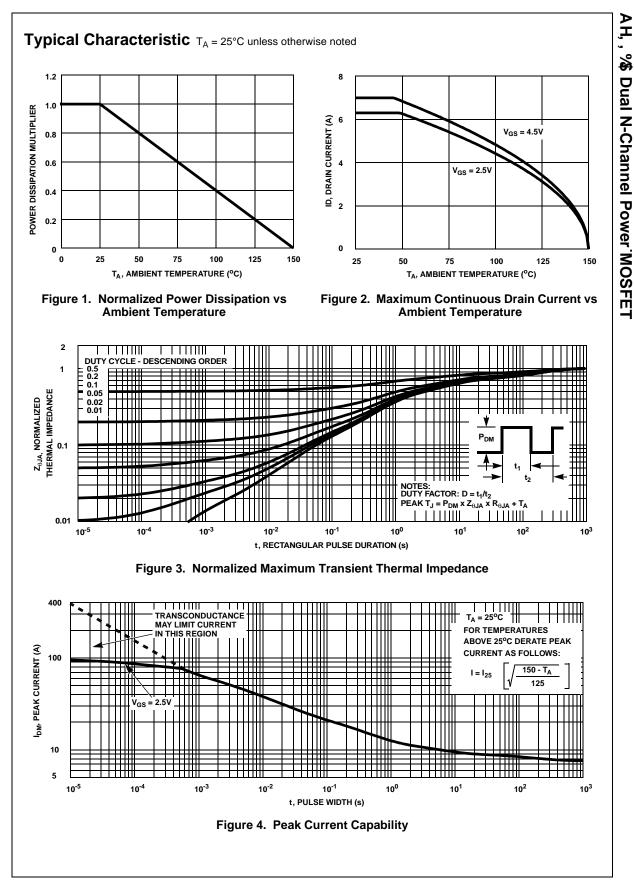
V_{SD}	Source to Drain Diode Voltage	I _{SD} = 1.3A	-	0.7	1.2	V
t _{rr}	Reverse Recovery Time	$I_{SD} = 7.1A$, $dI_{SD}/dt = 100A/\mu s$	-	-	27	ns
Q _{RR}	Reverse Recovered Charge	I _{SD} = 7.1A, dI _{SD} /dt = 100A/μs	-	-	16	nC

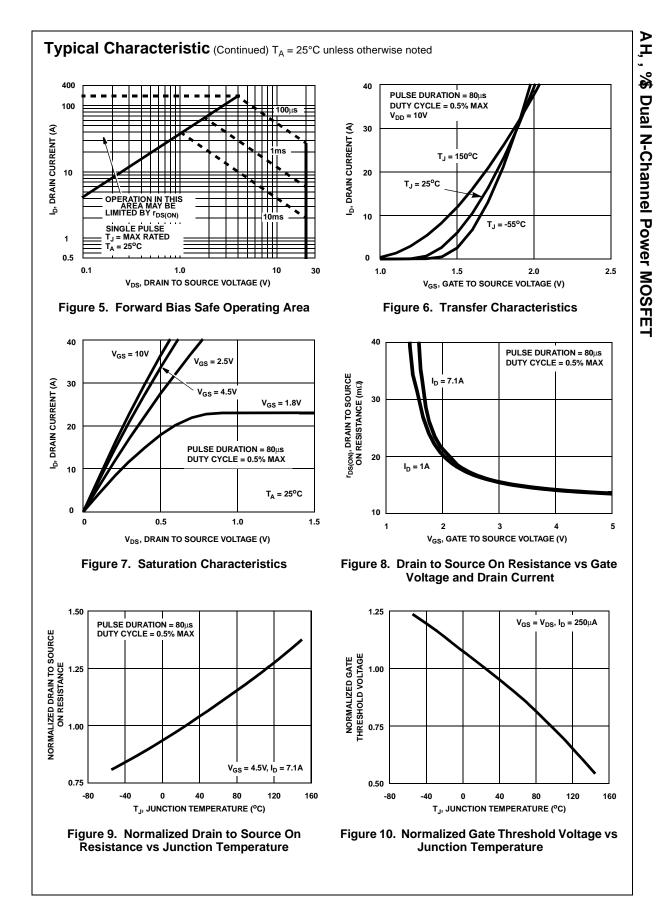
Notes:

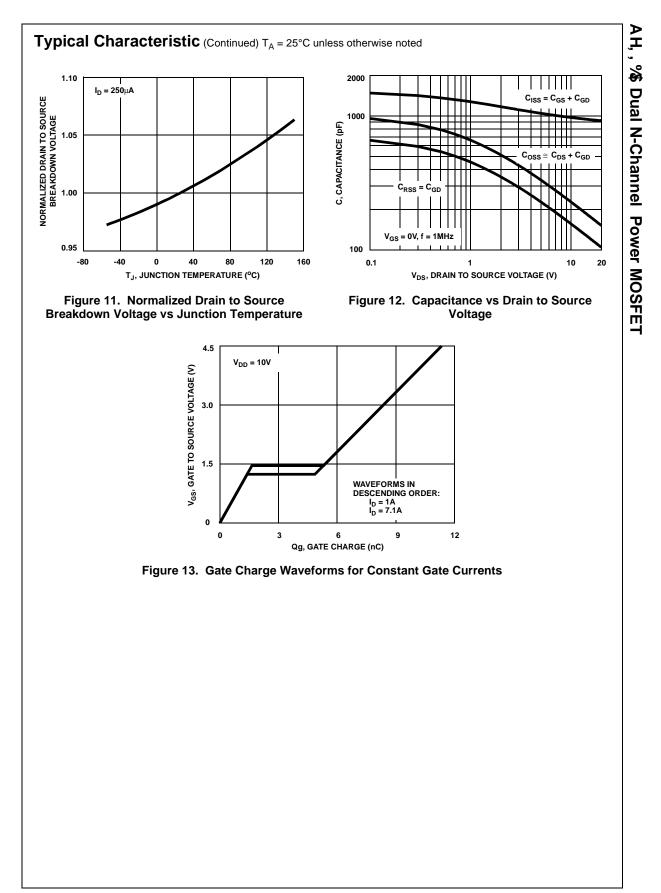
1. $R_{\theta JA}$ is 77 °C/W (steady state) when mounted on a 1 inch² copper pad on FR-4.

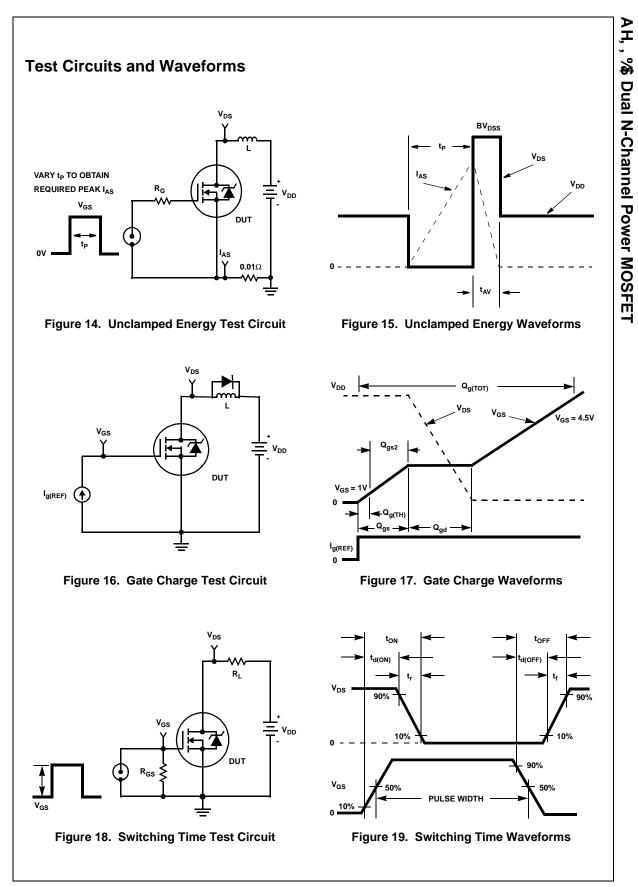
2. $R_{\theta JA}$ is 114 $^{o}\text{C/W}$ (steady state) when mounted on a mininum copper pad on FR-4.

3 The diode connected to the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

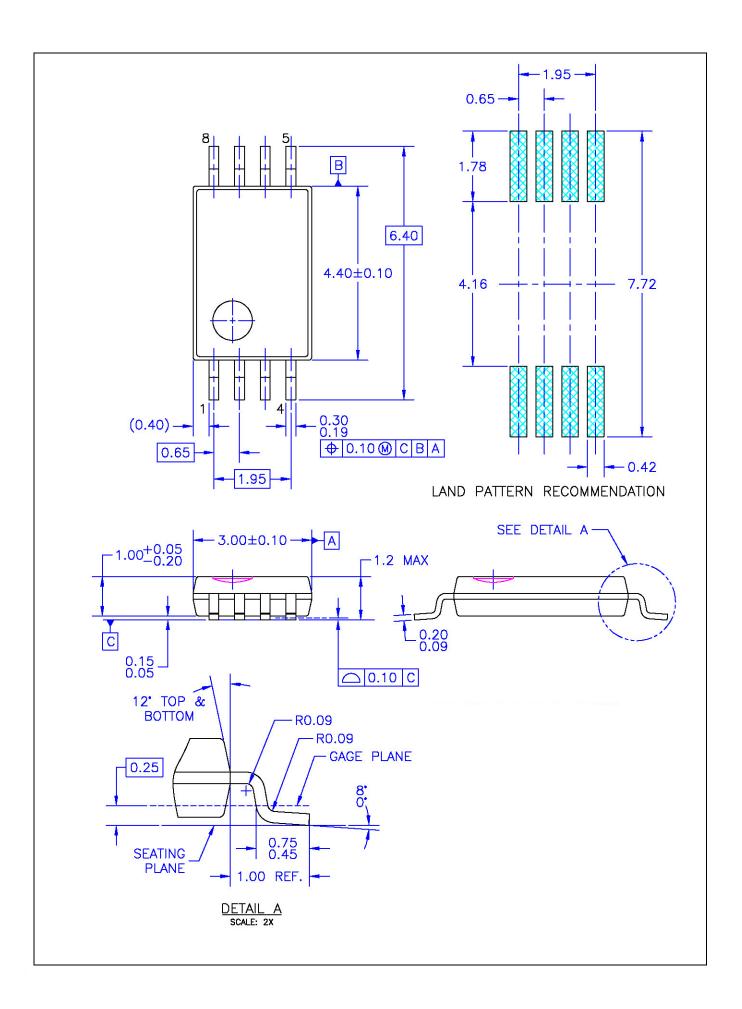


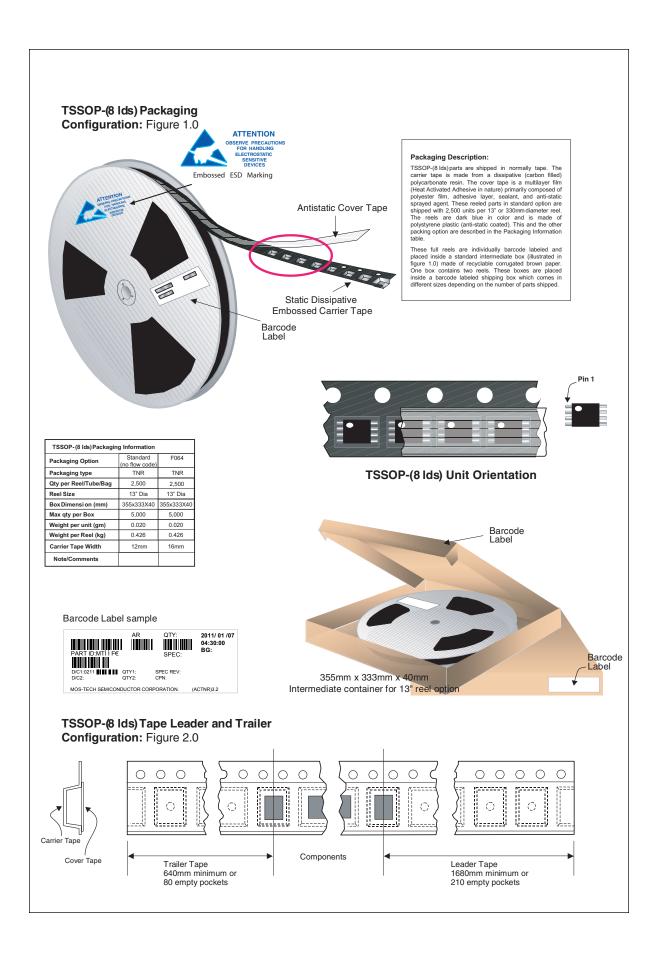


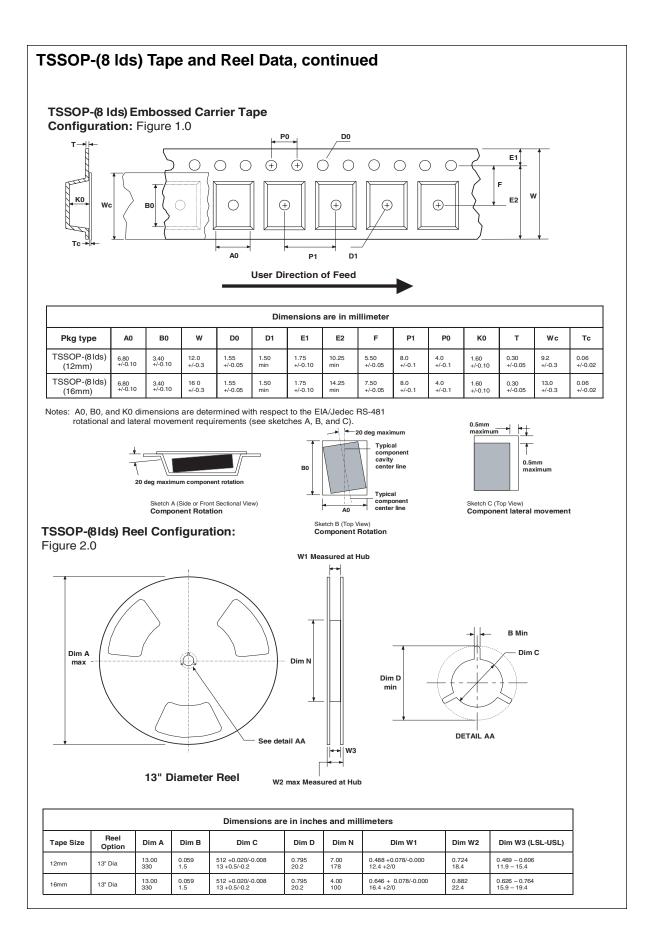




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 - (3) healthcare intervention (e.g., excision, administration of medication, etc.)
 - (4) any other purposes that pose a direct threat to human life

Mos-tech shall have no liability for damages arising out of the uses set forth in the above and purchasers who elect to use Mos-tech products in any of the foregoing applications shall indemnify and hold harmless Mos-tech Technology Corp., its affiliated companies and their officers, directors, and employees against any and all damages arising out of such applications.

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- 10. Although Mos-tech endeavors to improve the quality and reliability of its products, IC products have specific characteristics such as the occurrence of failure at a certain rate and malfunctions under certain use conditions. Please be sure to implement safety measures to guard against the possibility of physical injury, and injury or damage caused by fire in the event of the failure of a Mos-tech product, such as safety design for hardware and software including but not limited to redundancy, fire control and malfunction prevention, appropriate treatment for aging degradation or any other applicable measures. Among others, since the evaluation of microcomputer software alone is very difficult, please evaluate the safety of the final products or system manufactured by you.
- 11. In case Mos-tech products listed in this document are detached from the products to which the Mos-tech products are attached or affixed, the risk of accident such as swallowing by infants and small children is very high. You should implement safety measures so that Mos-tech products may not be easily detached from your products. Mos-techshall have no liability for damages arising out of such detachment.
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